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Product data sheet

1. General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

2. Features and benefits

- AEC Q101 compliant
- Electrostatically robust due to integrated protection diodes
- Low conduction losses due to low on-state resistance

3. Applications

Automotive and general purpose power switching

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C		-	-	55	V
I _D	drain current	T _{sp} = 25 °C		-	-	5.5	Α
P _{tot}	total power dissipation	T _{sp} = 25 °C; <u>Fig. 4</u>		-	-	8.3	W
Static characte	eristics						,
R _{DSon}	drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 5 \text{ A}; T_j = 25 \text{ °C}$		-	120	150	mΩ
Avalanche rug	Avalanche ruggedness						
E _{DS(AL)S}	non-repetitive drain- source avalanche energy	I_D = 1.9 A; $V_{sup} \le$ 25 V; R_{GS} = 50 Ω; V_{GS} = 5 V; $T_{j(init)}$ = 25 °C; unclamped		-	-	15	mJ





N-channel TrenchMOS logic level FET

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	4	D
2	D	drain		
3	S	source		G A
4	D	drain	H1 H2 H3 SC-73 (SOT223)	S sym116

6. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
BUK98150-55	SC-73	plastic surface-mounted package with increased heatsink; 4 leads	SOT223			
BUK98150-55/CU	SC-73	plastic surface-mounted package with increased heatsink; 4 leads	SOT223			

7. Marking

Table 4. Marking codes

Type number	Marking code
BUK98150-55	
BUK98150-55/CU	915055

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	55	V
V_{DGR}	drain-gate voltage	R_{GS} = 20 k Ω	-	55	V
V_{GS}	gate-source voltage		-10	10	V
P _{tot}	total power dissipation	T _{sp} = 25 °C; <u>Fig. 4</u>	-	8.3	W
I _D	drain current	T _{sp} = 25 °C	-	5.5	Α
		T _{sp} = 100 °C	-	3.5	Α

BUK98150-55

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N-channel TrenchMOS logic level FET

Symbol	Parameter	Conditions	Min	Max	Unit
I _{DM}	peak drain current	T _{sp} = 25 °C; pulsed	-	30	Α
T _{stg}	storage temperature		-55	150	°C
T _j	junction temperature		-55	150	°C
Source-drain o	liode				
I _S	source current	T _{sp} = 25 °C	-	5.5	Α
I _{SM}	peak source current	pulsed; T _{sp} = 25 °C	-	30	Α
Avalanche rug	gedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	I_D = 1.9 A; $V_{sup} \le$ 25 V; R_{GS} = 50 Ω; V_{GS} = 5 V; $T_{j(init)}$ = 25 °C; unclamped	-	15	mJ
Electrostatic d	lischarge				
V _{esd}	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 kΩ	-	2	kV

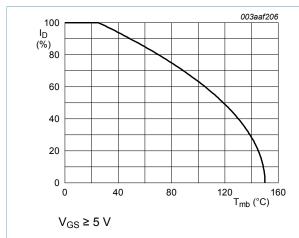


Fig. 1. Normalized continuous drain current as a function of mounting base temperature

$$I_{der} = \frac{I_D}{I_{D(25^{\circ}\text{C})}} \times 100\%$$

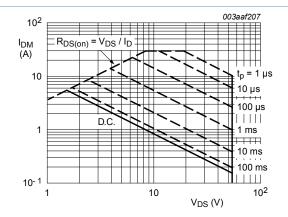


Fig. 2. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

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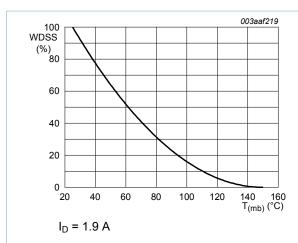


Fig. 3. Normalised drain-source non-repetitive avalanche energy rating; avalanche energy as a function of mounting base temperature

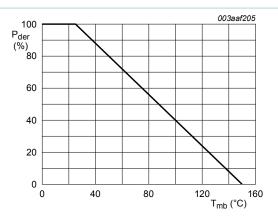


Fig. 4. Normalized total power dissipation as a function of mounting base temperature

$$P_{\textit{der}} = \frac{P_{\textit{tot}}}{P_{\textit{tot}(25^{\circ}C)}} \times 100\,\%$$

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-sp)}	thermal resistance from junction to solder point	mounted on any printed-circuit board	-	12	15	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	mounted on a printed-circuit board	-	120	-	K/W

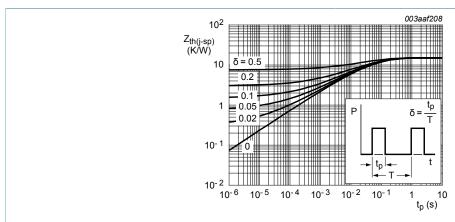


Fig. 5. Transient thermal impedance from junction to solder point as a function of pulse duration

N-channel TrenchMOS logic level FET

10. Characteristics

Table 7 Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics					
V _{(BR)DSS}	drain-source	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	55	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 ^{\circ}\text{C}$	50	-	-	V
V _{GS(th)}	gate-source threshold	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	1	1.5	2	V
	voltage	I_D = 1 mA; V_{DS} = V_{GS} ; T_j = -55 °C	-	-	2.3	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 150 °C	0.6	-	-	V
I _{DSS}	drain leakage current	V_{DS} = 55 V; V_{GS} = 0 V; T_j = 25 °C	-	0.05	10	μΑ
	V _{DS} = 55 V; V _{GS} = 0 V; T _j = 150 °C	-	-	100	μA	
I _{GSS}	gate leakage current	$V_{GS} = 5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	0.02	1	μΑ
		V _{GS} = -5 V; V _{DS} = 0 V; T _j = 25 °C	-	0.02	1	μΑ
		V _{GS} = 5 V; V _{DS} = 0 V; T _j = 150 °C	-	-	5	μA
		V _{GS} = -5 V; V _{DS} = 0 V; T _j = 150 °C	-	-	5	μA
R _{DSon}	drain-source on-state	V _{GS} = 5 V; I _D = 5 A; T _j = 150 °C	-	-	277	mΩ
	resistance	V _{GS} = 5 V; I _D = 5 A; T _j = 25 °C	-	120	150	mΩ
V _{(BR)GSS}	gate-source	$V_{DS} = 0 \text{ V; } T_j = 25 \text{ °C; } I_G = 1 \text{ mA}$	10	-	-	V
	breakdown voltage	$V_{DS} = 0 \text{ V; } T_j = 25 \text{ °C; } I_G = -1 \text{ mA}$	10	-	-	V
Dynamic ch	naracteristics					
C _{iss}	input capacitance	V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz;	-	250	330	pF
C _{oss}	output capacitance	T _j = 25 °C	-	65	80	pF
C _{rss}	reverse transfer capacitance		-	35	50	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 6 \Omega; V_{GS} = 5 \text{ V};$	-	11	17	ns
t _r	rise time	$R_{G(ext)} = 10 \Omega; T_j = 25 °C; I_D = 5 A$	-	38	60	ns
t _{d(off)}	turn-off delay time		-	25	38	ns
t _f	fall time		-	20	38	ns
9 _{fs}	transfer conductance	V_{DS} = 25 V; I_{D} = 5 A; T_{j} = 25 °C	3	5	-	S
Source-dra	in diode			'		,
V_{SD}	source-drain voltage	$I_S = 2 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	0.85	1.1	V
t _{rr}	reverse recovery time	$I_S = 2 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$	-	43	-	ns
Q _r	recovered charge $V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	0.16	-	μC	

N-channel TrenchMOS logic level FET

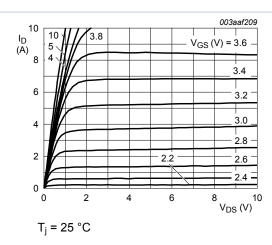


Fig. 6. Output characteristics: drain current as a function of drain-source voltage; typical values

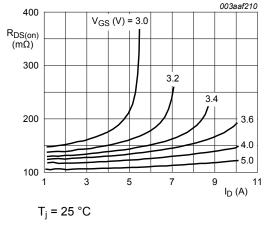


Fig. 7. Drain-source on-state resistance as a function of drain current; typical values

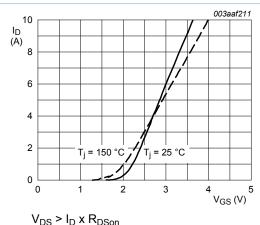


Fig. 8. Transfer characteristics: drain current as a function of gate-source voltage; typical values

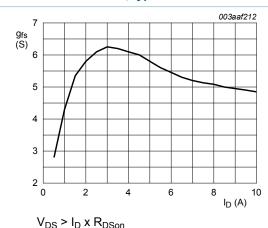


Fig. 9. Forward transconductance as a function of drain current; typical values

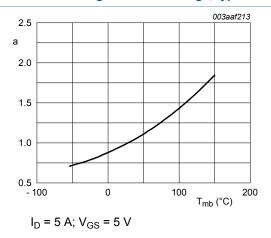


Fig. 10. Normalized drain-source on-state resistance factor as a function of junction temperature



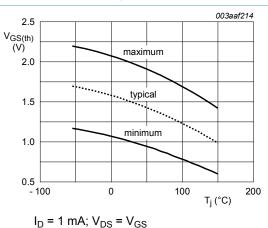


Fig. 11. Gate-source threshold voltage as a function of junction temperature

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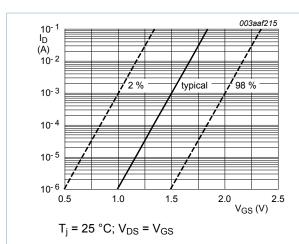


Fig. 12. Sub-threshold drain current as a function of gate-source voltage

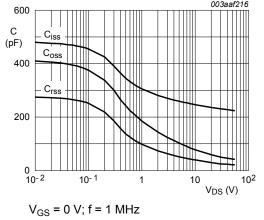


Fig. 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

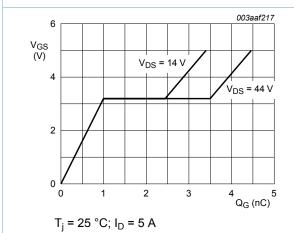


Fig. 14. Gate-source voltage as a function of gate charge; typical values

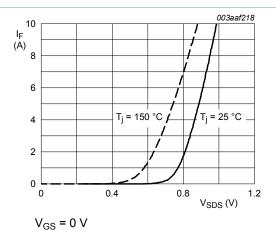
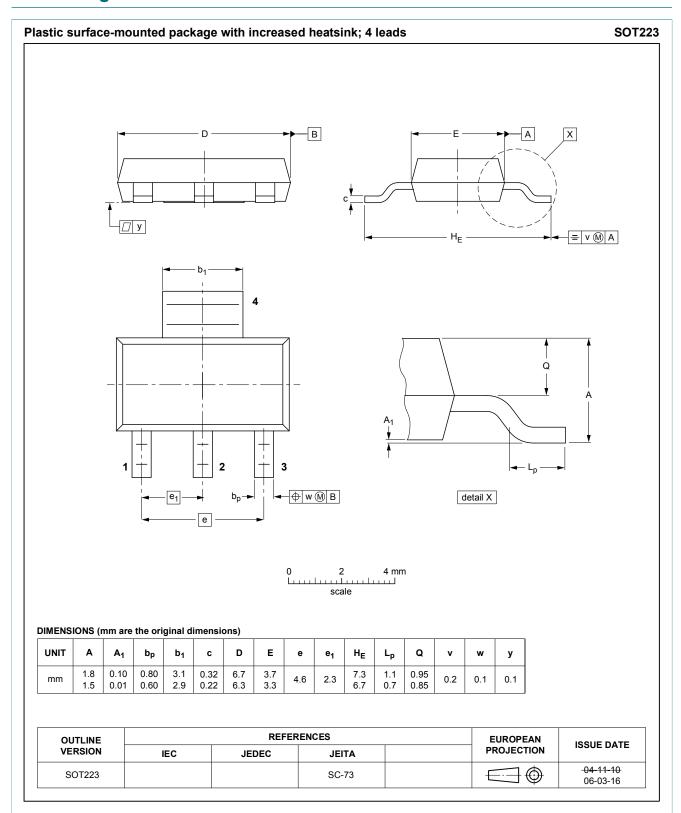


Fig. 15. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

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11. Package outline



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12. Legal information

12.1 Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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10 / 11

N-channel TrenchMOS logic level FET

13. Contents

1	General description	1
2	Features and benefits	1
3	Applications	1
4	Quick reference data	1
5	Pinning information	2
6	Ordering information	2
7	Marking	2
8	Limiting values	
9	Thermal characteristics	4
10	Characteristics	5
11	Package outline	8
12	Legal information	9
12.1	Data sheet status	g
12.2	Definitions	9
12.3	Disclaimers	9
12.4	Trademarks	10

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